



## Product Change Notification / ASER-06OYDX227

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### Date:

11-Jan-2022

### Product Category:

Ethernet PHYs

### PCN Type:

Manufacturing Change

### Notification Subject:

CCB 4999 Final Notice: Qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL.

### Affected CPNs:

[ASER-06OYDX227\\_Affected\\_CPN\\_01112022.pdf](#)

[ASER-06OYDX227\\_Affected\\_CPN\\_01112022.csv](#)

### Notification Text:

**PCN Status:**Final Notification

**PCN Type:**Manufacturing Change

**Microchip Parts Affected:**Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**Qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL.

### Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	ASE Group Chung-Li (ASCL)	ASE Group Chung-Li (ASCL)
Wire Material	Cu/CuPdAu	Cu/CuPdAu
Die Attach Material	EN-4900GC	EN-4900GC
Molding Compound Material	CEL-9240HF10AK	G700LA
Lead-Frame Material	C194	C194

**Impacts to Data Sheet:**None

**Change Impact:**None

**Reason for Change:**To improve manufacturability by qualifying G700LA as a new mold compound material.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:**February 17, 2022 (date code: 2208)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Time Table Summary:**

Workweek	January 2022					February 2022				
	1	2	3	4	5	6	7	8	9	10
Qual Report Availability			x							
Final PCN Issue Date			x							
Estimated Implementation Date							x			

**Method to Identify Change:**Traceability code

**Qualification Report:**Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:**January 11, 2022: Issued final notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

## **Attachments:**

[PCN\\_ASER-06OYDX227 Qual Report.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

## **Terms and Conditions:**

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If you wish to change your PCN profile, including opt out, please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

KSZ9031RNXCC

KSZ9031MNXCC

KSZ9031RNXIC

KSZ9031MNXIC

KSZ9031RNXCC-TR

KSZ9031MNXCC-TR

KSZ9031RNXIC-TR

KSZ9031MNXIC-TR



**MICROCHIP**

## **QUALIFICATION REPORT SUMMARY**

**PCN#: ASER-06OYDX227**

**Date:  
December 01, 2020**

**Qualification of ASCL as an additional assembly site for selected products available in 100L VQFN (12X12X0.9mm) package. The qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL will qualify by similarity (QBS). This is a grade 2 qualification.**



## MICROCHIP PACKAGE QUALIFICATION REPORT

<b>Purpose</b>	Qualification of ASCL as an additional assembly site for selected products available in 100L VQFN (12X12X0.9mm) package. The qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL will qualify by similarity (QBS). This is a grade 2 qualification.
<b>CCB</b>	4318 & 4999
<b>CN</b>	ES346385
<b>QUAL ID</b>	R2000670 Rev. A
<b>MP CODE</b>	STB07SKDXCH3
<b>Part No.</b>	USB5807CT/KDH01
<b>Bonding No.</b>	BDM-002651 Rev. A
<b><u>Package</u></b>	
<b>Type</b>	100L VQFN
<b>Package size</b>	12 x 12 x 0.9 mm
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	323 x 323 mils
<b>Material</b>	C7025
<b>Surface</b>	DOUBLE RING
<b>Process</b>	Etched
<b>Lead Lock</b>	No
<b>Part Number</b>	A0100QN008F01
<b><u>Material</u></b>	
<b>Epoxy</b>	EN-4900G
<b>Wire</b>	CuPdAu wire
<b>Mold Compound</b>	G700LA
<b>Plating Composition</b>	Matte Sn



## Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
ASCL211800001.000	TC14921152766.100	20311SD
ASCL211800002.000	TC14921152766.100	20311T3
ASCL211800003.000	TC14921152766.100	20311TS

### Result

Pass     Fail     \_\_\_\_\_

100L VQFN (12x12x0.9 mm) assembled by ASCL pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b>Precondition</b> <b>Prior Perform</b> <b>Reliability Tests</b> <b>(At MSL Level 3)</b>	<b>Electrical Test:</b> +25°C and 105°C System: LTX_D1X	JESD22-A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs System: CHINEE	JIP/IPC/JEDEC		693		
	30°C/60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH	J-STD-020E		693		
	3x Convection-Reflow 265°C max  System: Vitronics Soltec MR1243			693		
	<b>Electrical Test:</b> +25°C and 105°C System: LTX_D1X			0/693	Pass	



# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H <b>Electrical Test:</b> +105°C System: LTX_D1X	JESD22-A104		231		Parts had been pre-conditioned at 260°C  77 units / lot	
	<b>Stress Condition:</b> -65°C to +150°C, 1000 Cycles System: TABAI ESPEC TSA-70H <b>Electrical Test:</b> +105°C System: LTX_D1X		231(0)	0/231	Pass		
	<b>Bond Strength:</b> Wire Pull (> 2.5 grams) Bond Shear (> 13.00 grams)		15 (0)	0/15	Pass		
			15 (0)	0/15	Pass		
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X <b>Electrical Test:</b> +25°C and 105°C System: LTX_D1X	JESD22-A118		231		Parts had been pre-conditioned at 260°C  77 units / lot	
			231(0)	0/231	Pass		
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> 1.20 Volts, PS3# 3.3 Volts System: HAST 6000X <b>Electrical Test:</b> + 25°C and 105°C System: LTX_D1X	JESD22-A110		231		Parts had been pre-conditioned at 260°C  77 units / lot	
	<b>Stress Condition:</b> +130°C/85%RH, 192 hrs. <b>Bias Volt:</b> 1.20 Volts, PS3# 3.3 Volts System: HAST 6000X <b>Electrical Test:</b> + 25°C and 105°C System: LTX_D1X		231(0)	0/231	Pass		
				231			
			231(0)	0/231	Pass		

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 150°C, 500 hrs System: SHEL LAB	JESD22-A103		45		45 units
	<b>Electrical Test:</b> +25°C and 105°C System: LTX_D1X		45(0)	0/45	Pass	
	<b>Stress Condition:</b> Bake 150°C, 1000 hrs System: SHEL LAB			45		
	<b>Electrical Test:</b> +25°C and 105°C System: LTX_D1X		45(0)	0/45	Pass	
<b>Solderability Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22 0/22	Pass	
<b>Physical Dimensions</b>	Physical Dimension, 10 units from 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength Data Assembly</b>	Wire Pull (> 3.00 grams)	Mil.Std. 883-2011	30 (0) Wires	0/30	Pass	
	Bond Shear (> 8.00 grams)	CDF-AEC-Q100-001	30 (0) bonds	0/30	Pass	



**MICROCHIP**

## **QUALIFICATION REPORT SUMMARY**

**PCN#: ASER-06OYDX227**

**Date:  
October 10, 2019**

**Qualification of OS81210AFxxx device family available in 64L VQFN package at ASCL. The qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL will qualify by similarity (QBS). This is a grade 1 qualification.**

<b>Purpose</b>	Qualification of OS81210AFxxx device family available in 64L VQFN package at ASCL. The qualification of G700LA as a new mold compound for selected KSZ9031xxx device family available in 48L VQFN (7x7x0.9mm) and 64L VQFN (8x8x0.9mm) packages assembled at ASCL will qualify by similarity (QBS). This is a grade 1 qualification.
<b>CCB</b>	3380 & 4999
<b>CN</b>	ES309183 Rev. A
<b>QUAL ID</b>	Q19011
<b>MP CODE</b>	TAV037KJXACC
<b>Part No.</b>	OS81210AF-B1A-ACC
<b>Bonding No.</b>	BDE-005072 Rev. 01
<b><u>Package</u></b>	
<b>Type</b>	64L VQFN
<b>Package size</b>	9x9x0.9 mm
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	244 x 244 mils
<b>Material</b>	C194
<b>Surface</b>	Double Ring Plating / Roughened
<b>Process</b>	Etched
<b>Lead Lock</b>	Yes
<b>Part Number</b>	A0064QN059F01
<b><u>Material</u></b>	
<b>Epoxy</b>	EN-4900G
<b>Wire</b>	CuPdAu wire
<b>Mold Compound</b>	G700LA
<b>Plating Composition</b>	Matte Tin

## Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
ASCL194200236.000	TC11919244995.000	1903TM7
ASCL194300003.000	TC11919364181.000	1904TM8
ASCL201200145.000	TC11920106913.000	1925R2G

Result

Pass

Fail

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64L QFN (9x9x0.9 mm) assembled by ASCL pass reliability test per QCI-39000.  
This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C  
reflow temperature per IPC/JEDEC J-STD-020E standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b>Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)</b>	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243  ( IPC/JEDEC J-STD-020E)	IPC/JEDEC C J-STD-020E	135	0/135	Pass	

<b><u>Precondition Prior Perform Reliability Tests (At MSL Level 1)</u></b>	<b>Electrical Test</b> :+25°C, 130°C and -45°C System: Teradyne Uflex	JESD22-A113	693(0)	693	Pass	Good Devices
	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	<b>Electrical Test</b> :+25°C and 130°C System: Teradyne Uflex			0/693		

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System : TABAI ESPEC TSA-70H <b>Electrical Test:</b> + 130°C System: ULTRAFLEX_12 <b>C-SAM Inspection</b> Focus on die surface, Lead finger, and paddle System: HITACHI (FS200)  <b>Cross section</b>  <b>Stress Condition:</b> -65°C to +150°C, 1000 Cycles System : TABAI ESPEC TSA-70H <b>Electrical Test:</b> + 130°C System: ULTRAFLEX_12 <b>C-SAM Inspection</b> Focus on die surface, Lead finger, and paddle System: HITACHI (FS200)  <b>Cross section</b>	JESD22- A104		231			Parts had been pre-conditioned at 260°C
			231(0)	0/231	Pass		
			66 (0)	0 /66	Pass	22 units / lot	
			15 (0)	0/15	Pass	1 Wire/ lot	
			45 (0)	0/45	Pass		
			3(0) Wires	0/3	Pass		
				231			22 units / lot
			231(0)	0/231	Pass		
			66 (0)	0 /66	Pass	1 Wire/ lot	
			15 (0)	0/15	Pass		
			45 (0)	0/45	Pass		
			3(0) Wires	0/3	Pass		

# PACKAGE QUALIFICATION REPORT

Qual Report : Q19011

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> PS1=3.3 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> + 25°C and 130°C System: ULTRAFLEX_12		231(0)	0/231	Pass	77 units / lot
	<b>C-SAM Inspection</b> Focus on die surface, Lead finger, and paddle System: HITACHI (FS200)		66 (0)	0 /66	Pass	22 units / lot
			15 (0)	0/15	Pass	
	<b>Cross section</b>		45 (0)	0/45	Pass	1Wire/ lot
	<b>Stress Condition:</b> +130°C/85%RH, 192 hrs. <b>Bias Volt:</b> PS1=3.3 Volts System: HAST 6000X		3(0) Wires	0/3	Pass	
	<b>Electrical Test:</b> + 25°C and 130°C System: ULTRAFLEX_12			231		
	<b>C-SAM Inspection</b> Focus on die surface, Lead finger, and paddle System: HITACHI (FS200)		231(0)	0/231	Pass	22 units / lot
			66 (0)	0 /66	Pass	after HAST
	<b>Cross section</b>		15 (0)	0/15	Pass	1 Wire/ lot
			45 (0)	0/45	Pass	
			3(0) Wires	0/3	Pass	



# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22-A118		231		Parts had been pre-conditioned at 260°C
	<b>Electrical Test:</b> +25°C System: ULTRAFLEX_12		231(0)	0/231	Pass	77 units / lot
	<b>Stress Condition:</b> +130°C/85%RH, 192 hrs. System: HAST 6000X			231		
	<b>Electrical Test:</b> +25°C System: J750		231(0)	0/231	Pass	
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 504 hrs System: SHEL LAB	JESD22-A103		135		45 units / lot
	<b>Electrical Test:</b> + 25°C and 130°C System: ULTRAFLEX_12		135(0)	0/135	Pass	
	<b>Cross section</b>		3(0) Wires	0/3	Pass	1 Wire/ lot
	<b>Stress Condition:</b> Bake 175°C, 1008 hrs System: SHEL LAB			135		
	<b>Electrical Test:</b> + 25°C and 130°C System: ULTRAFLEX_12		135(0)	0/135	Pass	
	<b>Cross section</b>		3(0) Wires	0/3	Pass	1 Wire/ lot
<b>Solderability Temp 215°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22 0/22	Pass	
<b>Solderability Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22 0/22	Pass	

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Physical Dimensions</b>	Physical Dimension, 10 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength Data Assembly</b>	Wire Pull (> 4.00 grams)	M2011	30 (0) Wires	0/30 0/30	Pass	
	Bond Shear (>10.00 grams)	JESD22- B116	30 (0) bonds		Pass	